
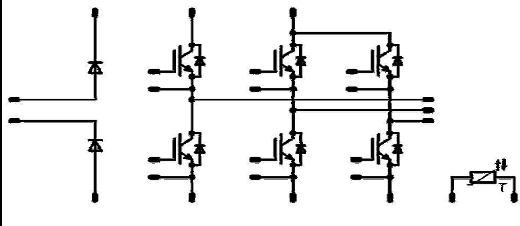




<p>flowPACK 2</p> <div style="border: 1px solid black; padding: 5px; margin-bottom: 10px;"> <p style="text-align: center; background-color: #cccccc; margin: 0;">Features</p> <ul style="list-style-type: none"> Inverter, blocking diodes Built-in thermistor </div> <div style="border: 1px solid black; padding: 5px; margin-bottom: 10px;"> <p style="text-align: center; background-color: #cccccc; margin: 0;">Target Applications</p> <ul style="list-style-type: none"> Power Regeneration </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; background-color: #cccccc; margin: 0;">Types</p> <ul style="list-style-type: none"> 30-F206R6A100SB-M444E 30-F206R6A100SB01-M444E10 </div>	<p style="text-align: right;">600V/100A</p> <div style="border: 1px solid black; padding: 5px; margin-bottom: 10px;"> <p style="text-align: center; background-color: #cccccc; margin: 0;">flow 2 housing</p>  </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; background-color: #cccccc; margin: 0;">Schematic</p>  </div>
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Maximum Ratings

$T_j=25^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
DC Blocking Diode				
Repetitive peak reverse voltage	V_{RRM}		1600	V
DC forward current	I_{FAV}	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	154 208	A
Surge forward current	I_{FSM}	$t_p=10\text{ms}$ $T_j=25^{\circ}\text{C}$	1270	A
I^2t -value	I^2t		2400	A^2s
Power dissipation per Diode	P_{tot}	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	189 287	W
Maximum Junction Temperature	T_{jmax}		150	$^{\circ}\text{C}$
Inverter Switch				
Collector-emitter break down voltage	V_{CE}		600	V
DC collector current	I_C	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	111 120	A
Pulsed collector current	I_{Cpulse}	t_p limited by T_{jmax}	300	A
Turn off safe operating area		$V_{CE} \leq 1200\text{V}$, $T_j \leq T_{op max}$	300	A
Power dissipation per IGBT	P_{tot}	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	209 317	W
Gate-emitter peak voltage	V_{GE}		± 20	V
Short circuit ratings	t_{SC} V_{CC}	$T_j \leq 150^{\circ}\text{C}$ $V_{GE}=15\text{V}$	5 400	μs V
Maximum Junction Temperature	T_{jmax}		175	$^{\circ}\text{C}$

**Maximum Ratings** $T_j=25^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
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Inverter Diode

Peak Repetitive Reverse Voltage	V_{RRM}		600	V
DC forward current	I_F	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	59 60	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}	100	A
Power dissipation per Diode	P_{tot}	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	94 143	W
Maximum Junction Temperature	T_{jmax}		175	$^{\circ}\text{C}$

Thermal Properties

Storage temperature	T_{stg}		-40...+125	$^{\circ}\text{C}$
Operation temperature under switching condition	T_{op}		-40...+($T_{jmax} - 25$)	$^{\circ}\text{C}$

Insulation Properties

Insulation voltage	V_{is}	$t=2\text{s}$ DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm
Comparative tracking index	CTI		>200	



Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}[V]$ or $V_{GS}[V]$	$V_r[V]$ or $V_{CE}[V]$ or $V_{DS}[V]$	$I_c[A]$ or $I_F[A]$ or $I_b[A]$	T_j	Min	Typ	Max		

DC Blocking Diode

Forward voltage	V_F				100	$T_j=25^\circ C$ $T_j=125^\circ C$	1,12 1,07	1,21		V
Threshold voltage (for power loss calc. only)	V_{to}				100	$T_j=25^\circ C$ $T_j=125^\circ C$	0,89 0,76			V
Slope resistance (for power loss calc. only)	r_t				100	$T_j=25^\circ C$ $T_j=125^\circ C$	2 3			m Ω
Reverse current	I_r			1600		$T_j=25^\circ C$ $T_j=125^\circ C$		0,05		mA
Thermal resistance chip to heatsink per chip	R_{thJH}	Phase-Change Material					0,37			K/W
Thermal resistance chip to heatsink per chip	R_{thJC}						0,24			K/W

Inverter Switch

Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$			0,0016	$T_j=25^\circ C$ $T_j=150^\circ C$	5 5,8	6,5		V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		100	$T_j=25^\circ C$ $T_j=150^\circ C$	1,05 1,48 1,73	1,85		V
Collector-emitter cut-off current incl. Diode	I_{CES}		0	600		$T_j=25^\circ C$ $T_j=150^\circ C$		0,006		mA
Gate-emitter leakage current	I_{GES}		20	0		$T_j=25^\circ C$ $T_j=150^\circ C$		1200		nA
Integrated Gate resistor	R_{gint}						none			Ω
Turn-on delay time	$t_{d(on)}$	$R_{goff}=4 \Omega$ $R_{gon}=4 \Omega$	± 15	300	100	$T_j=25^\circ C$ $T_j=150^\circ C$	115 116		ns	
Rise time	t_r					$T_j=25^\circ C$ $T_j=150^\circ C$	22 25			
Turn-off delay time	$t_{d(off)}$					$T_j=25^\circ C$ $T_j=150^\circ C$	172 198			
Fall time	t_f					$T_j=25^\circ C$ $T_j=150^\circ C$	72 104			
Turn-on energy loss per pulse	E_{on}					$T_j=25^\circ C$ $T_j=150^\circ C$	0,69 1,12	mWs		
Turn-off energy loss per pulse	E_{off}	$T_j=25^\circ C$ $T_j=150^\circ C$	2,77 4,01							
Input capacitance	C_{ies}						6280		pF	
Output capacitance	C_{oss}	$f=1MHz$	0	25		$T_j=25^\circ C$	400			
Reverse transfer capacitance	C_{rss}						186			
Gate charge	Q_{Gate}		± 15	480	100	$T_j=25^\circ C$	620		nC	
Thermal resistance chip to heatsink per chip	R_{thJH}	Phase-Change Material					0,45		K/W	
Thermal resistance chip to case per chip	R_{thJC}						0,3			

Inverter Diode

Diode forward voltage	V_F				50	$T_j=25^\circ C$ $T_j=150^\circ C$	1,1 1,63 1,52	2,2		V
Peak reverse recovery current	I_{RRM}	$R_{gon}=4 \Omega$	± 15	300	100	$T_j=25^\circ C$ $T_j=150^\circ C$	70,04 86,7		A	
Reverse recovery time	t_{rr}					$T_j=25^\circ C$ $T_j=150^\circ C$	117,3 269,7			
Reverse recovered charge	Q_{rr}					$T_j=25^\circ C$ $T_j=150^\circ C$	3,48 7,48	μC		
Peak rate of fall of recovery current	$di(rec)max/dt$					$T_j=25^\circ C$ $T_j=150^\circ C$	5512 2501	A/ μs		
Reverse recovered energy	E_{rec}					$T_j=25^\circ C$ $T_j=150^\circ C$	0,88 1,91	mWs		
Thermal resistance chip to heatsink per chip	R_{thJH}	Phase-Change Material					1,01		K/W	
Thermal resistance chip to case per chip	R_{thJC}						0,67			

Thermistor

Rated resistance	R					$T_j=25^\circ C$	22000		Ω
Deviation of R100	$\Delta R/R$	R100=1486 Ω				T=100 $^\circ C$	-12	14	%
Power dissipation	P					Tc=100 $^\circ C$	200		mW
Power dissipation constant						$T_j=25^\circ C$	2		mW/K
B-value	$B_{(25/50)}$	Tol. $\pm 3\%$				$T_j=25^\circ C$	3950		K
B-value	$B_{(25/100)}$	Tol. $\pm 3\%$				$T_j=25^\circ C$	3998		K
Vincotech NTC Reference						$T_j=25^\circ C$		B	



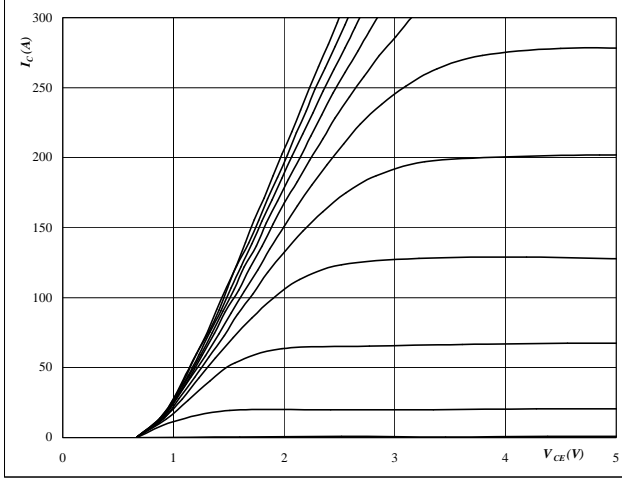
Vincotech

T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b/D1,D2,D3,D4,D5,D6

Figure 1 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Typical output characteristics

$I_C = f(V_{CE})$

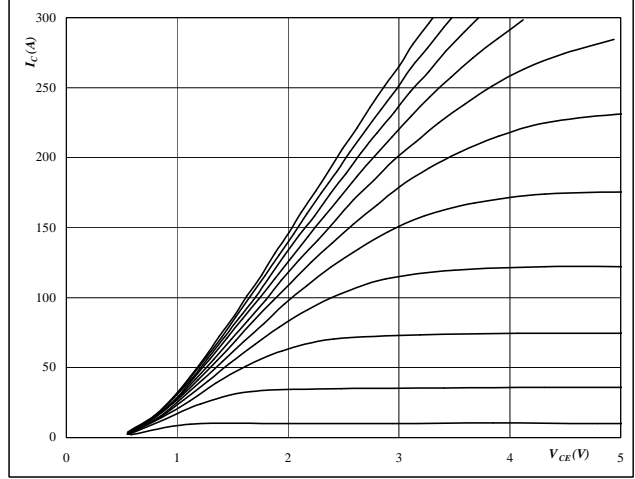


At
 $t_p = 250 \mu s$
 $T_j = 25 \text{ } ^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 2 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Typical output characteristics

$I_C = f(V_{CE})$

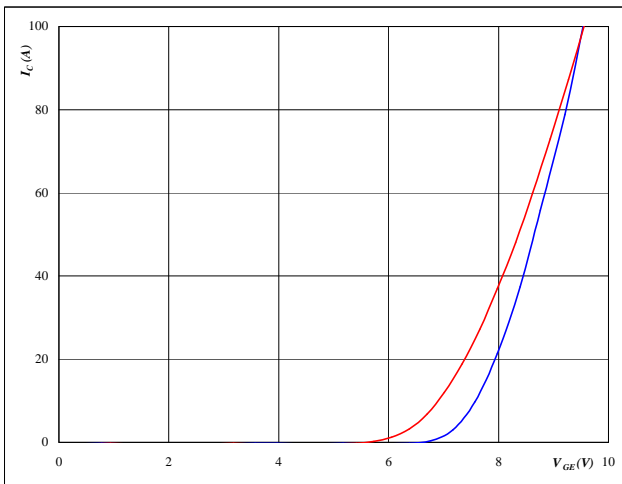


At
 $t_p = 250 \mu s$
 $T_j = 150 \text{ } ^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 3 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Typical transfer characteristics

$I_C = f(V_{GE})$

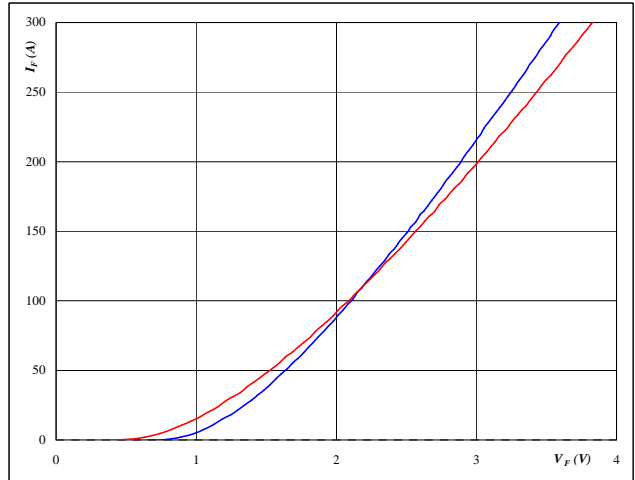


At
 $T_j = 25/150 \text{ } ^\circ C$
 $t_p = 250 \mu s$
 $V_{CE} = 10 \text{ V}$

Figure 4 D1,D2,D3,D4,D5,D6 FWD

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$



At
 $T_j = 25/150 \text{ } ^\circ C$
 $t_p = 250 \mu s$



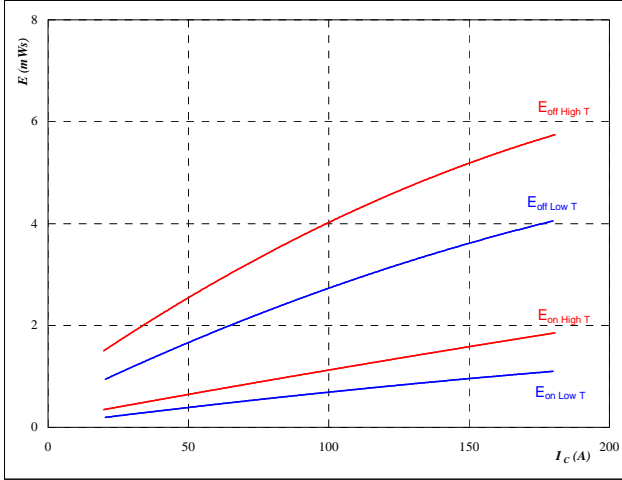
Vincotech

T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b/D1,D2,D3,D4,D5,D6

Figure 5 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Typical switching energy losses
as a function of collector current

$E = f(I_C)$



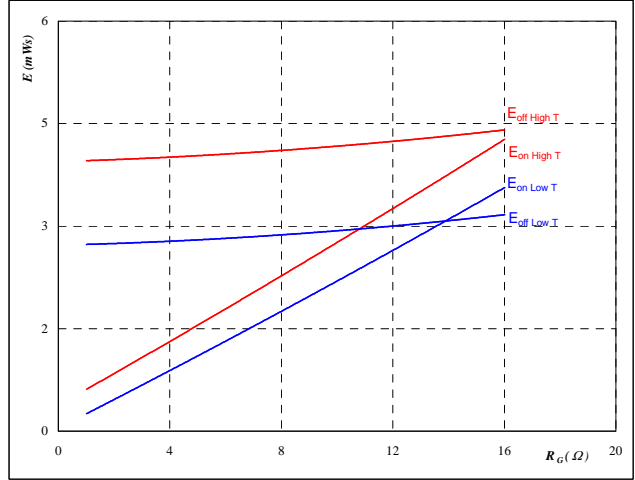
With an inductive load at

- $T_J = 25/150$ °C
- $V_{CE} = 300$ V
- $V_{GE} = \pm 15$ V
- $R_{gon} = 4$ Ω
- $R_{goff} = 4$ Ω

Figure 6 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Typical switching energy losses
as a function of gate resistor

$E = f(R_G)$



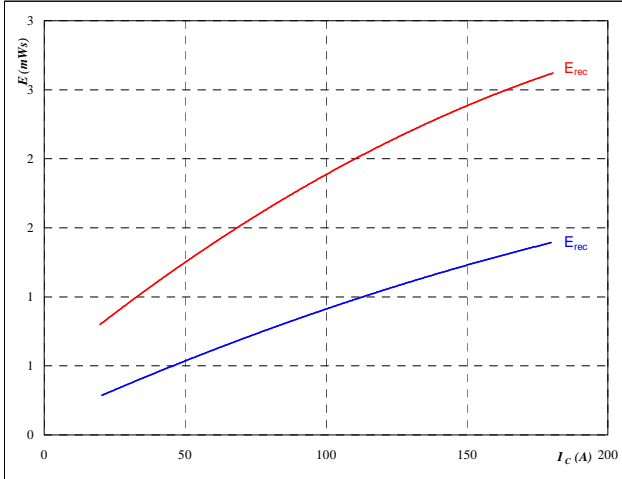
With an inductive load at

- $T_J = 25/150$ °C
- $V_{CE} = 300$ V
- $V_{GE} = \pm 15$ V
- $I_C = 100$ A

Figure 7 D1,D2,D3,D4,D5,D6 FWD

Typical reverse recovery energy loss
as a function of collector current

$E_{rec} = f(I_C)$



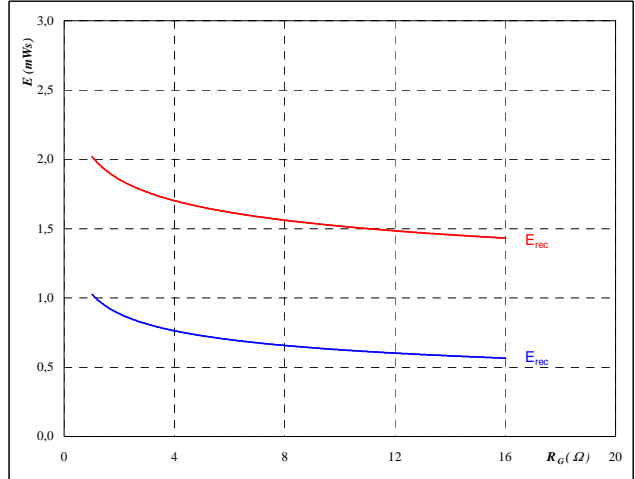
With an inductive load at

- $T_J = 25/150$ °C
- $V_{CE} = 300$ V
- $V_{GE} = \pm 15$ V
- $R_{gon} = 4$ Ω

Figure 8 D1,D2,D3,D4,D5,D6 FWD

Typical reverse recovery energy loss
as a function of gate resistor

$E_{rec} = f(R_G)$



With an inductive load at

- $T_J = 25/150$ °C
- $V_{CE} = 300$ V
- $V_{GE} = \pm 15$ V
- $I_C = 100$ A



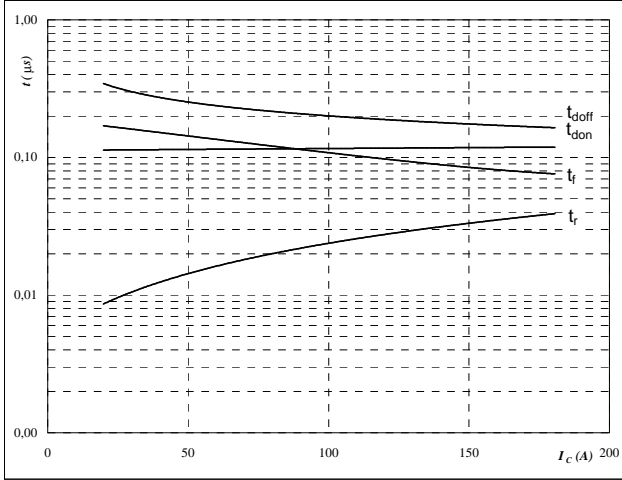
Vincotech

T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b/D1,D2,D3,D4,D5,D6

Figure 9 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Typical switching times as a function of collector current

$t = f(I_C)$



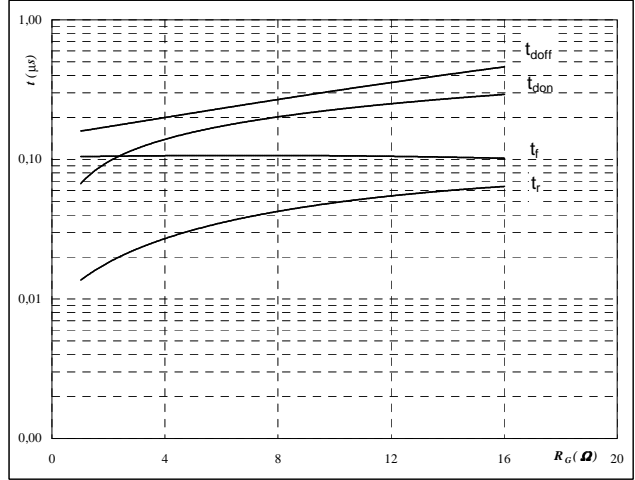
With an inductive load at

$T_J =$	150	°C
$V_{CE} =$	300	V
$V_{GE} =$	±15	V
$R_{gon} =$	4	Ω
$R_{goff} =$	4	Ω

Figure 10 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Typical switching times as a function of gate resistor

$t = f(R_G)$



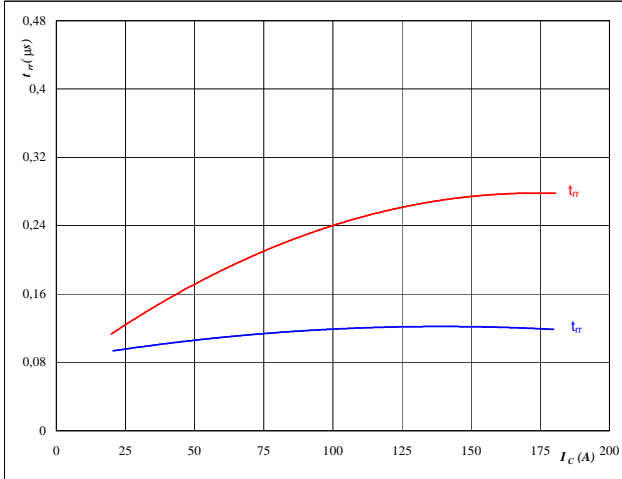
With an inductive load at

$T_J =$	150	°C
$V_{CE} =$	300	V
$V_{GE} =$	±15	V
$I_C =$	100	A

Figure 11 D1,D2,D3,D4,D5,D6 FWD

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$



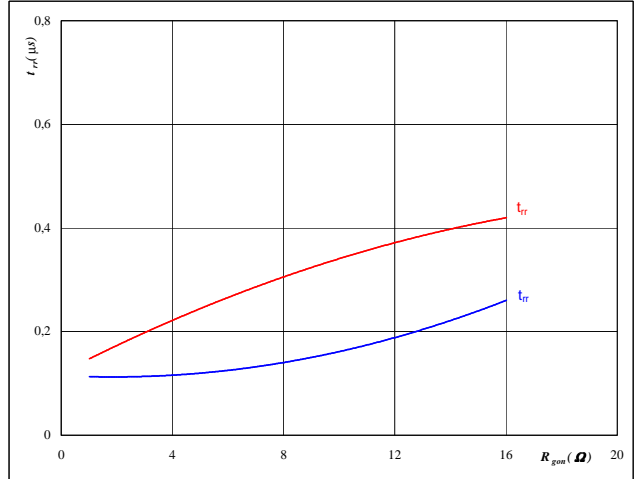
At

$T_J =$	25/150	°C
$V_{CE} =$	300	V
$V_{GE} =$	±15	V
$R_{gon} =$	4	Ω

Figure 12 D1,D2,D3,D4,D5,D6 FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



At

$T_J =$	25/150	°C
$V_R =$	300	V
$I_F =$	100	A
$V_{GE} =$	±15	V



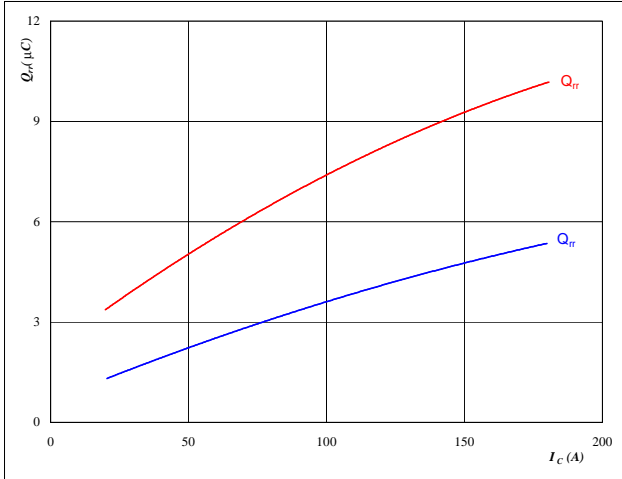
Vincotech

T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b/D1,D2,D3,D4,D5,D6

Figure 13 D1,D2,D3,D4,D5,D6 FWD

Typical reverse recovery charge as a function of collector current

$Q_{rr} = f(I_C)$

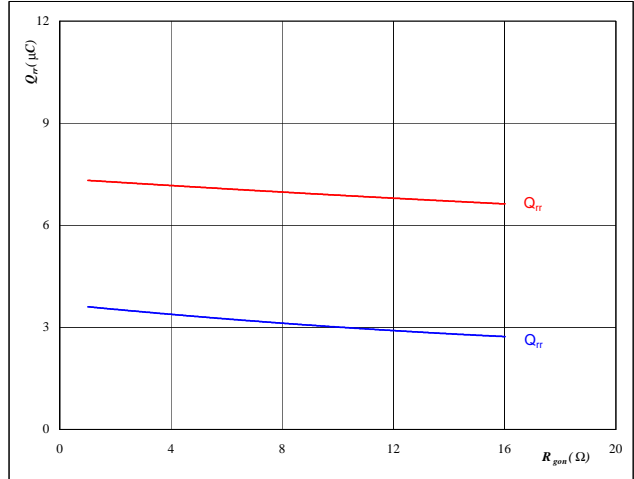


At
 $T_j = 25/150$ °C
 $V_{CE} = 300$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 4$ Ω

Figure 14 D1,D2,D3,D4,D5,D6 FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$Q_{rr} = f(R_{gon})$

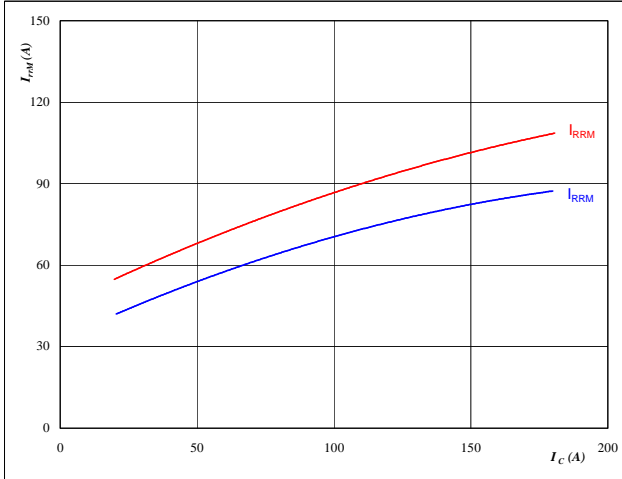


At
 $T_j = 25/150$ °C
 $V_R = 300$ V
 $I_F = 100$ A
 $V_{GE} = \pm 15$ V

Figure 15 D1,D2,D3,D4,D5,D6 FWD

Typical reverse recovery current as a function of collector current

$I_{RRM} = f(I_C)$

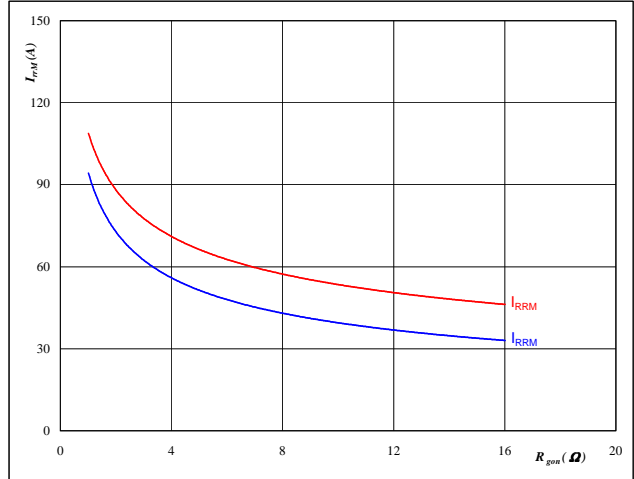


At
 $T_j = 25/150$ °C
 $V_{CE} = 300$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 4$ Ω

Figure 16 D1,D2,D3,D4,D5,D6 FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$I_{RRM} = f(R_{gon})$



At
 $T_j = 25/150$ °C
 $V_R = 300$ V
 $I_F = 100$ A
 $V_{GE} = \pm 15$ V



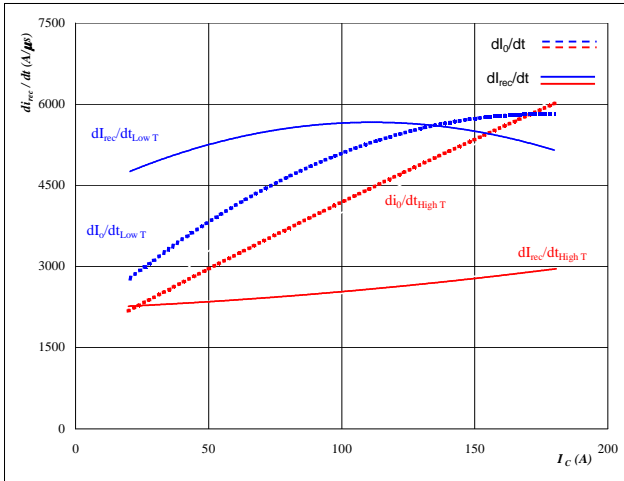
Vincotech

T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b/D1,D2,D3,D4,D5,D6

Figure 17 D1,D2,D3,D4,D5,D6 FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

$dI_f/dt, dI_{rec}/dt = f(I_C)$

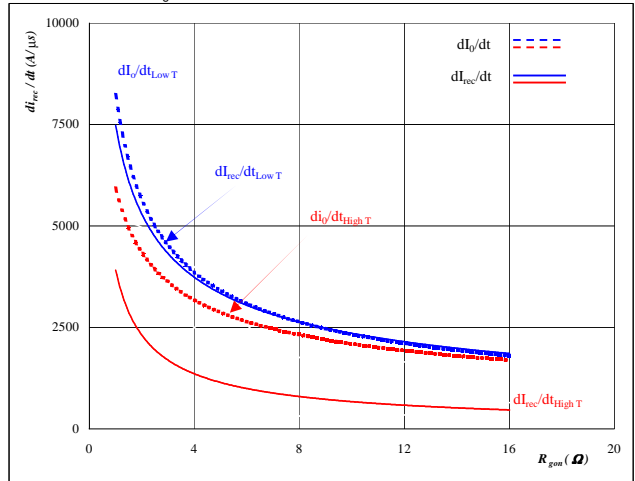


At
 $T_j = 25/150 \text{ } ^\circ\text{C}$
 $V_{CE} = 300 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 4 \text{ } \Omega$

Figure 18 D1,D2,D3,D4,D5,D6 FWD

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$dI_f/dt, dI_{rec}/dt = f(R_{gon})$

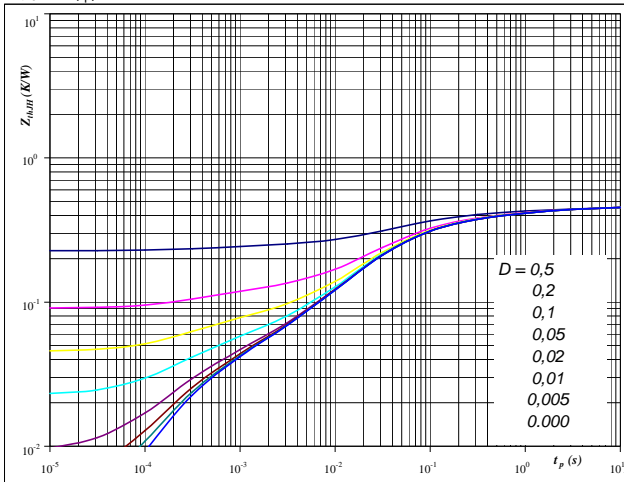


At
 $T_j = 25/150 \text{ } ^\circ\text{C}$
 $V_R = 300 \text{ V}$
 $I_F = 100 \text{ A}$
 $V_{GE} = \pm 15 \text{ V}$

Figure 19 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

IGBT transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At
 $D = t_p / T$
 $R_{thJH} = 0,45 \text{ K/W}$

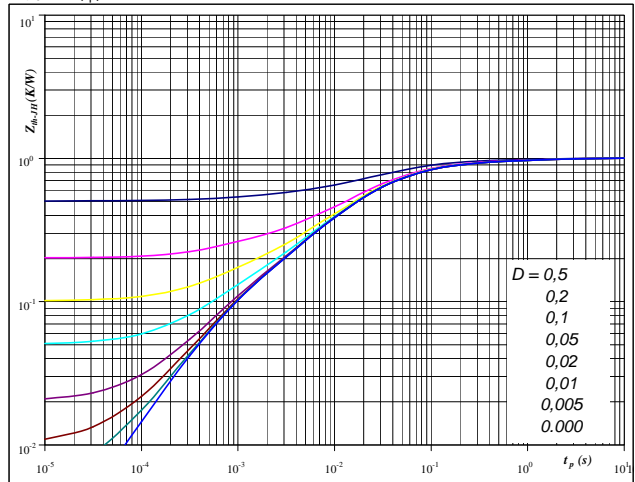
IGBT thermal model values

Phase-Change Material	
R (C/W)	Tau (s)
0,06	2,2E+00
0,07	3,3E-01
0,16	6,7E-02
0,12	1,8E-02
0,02	2,1E-03
0,03	3,0E-04

Figure 20 D1,D2,D3,D4,D5,D6 FWD

FWD transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At
 $D = t_p / T$
 $R_{thJH} = 1,01 \text{ K/W}$

FWD thermal model values

Phase-Change Material	
R (C/W)	Tau (s)
0,04	3,5E+00
0,08	4,7E-01
0,28	7,2E-02
0,41	2,0E-02
0,13	5,0E-03
0,07	6,9E-04



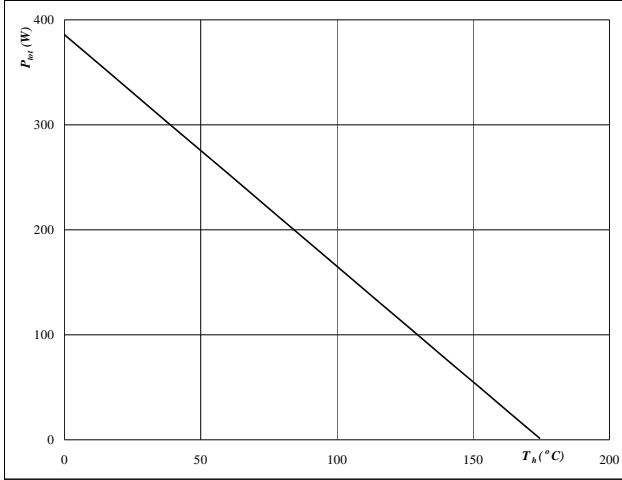
Vincotech

T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b/D1,D2,D3,D4,D5,D6

Figure 21 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$

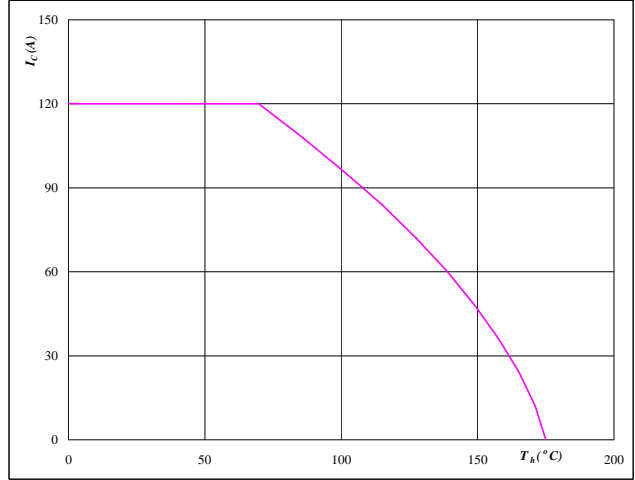


At
 $T_j = 175$ °C

Figure 22 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Collector current as a function of heatsink temperature

$I_C = f(T_h)$

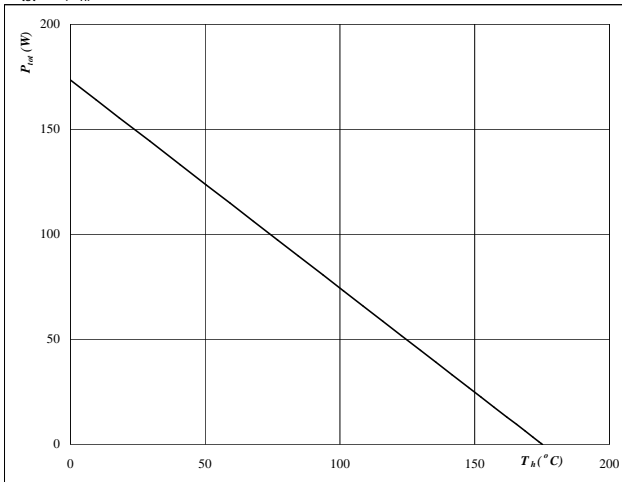


At
 $T_j = 175$ °C
 $V_{GE} = 15$ V

Figure 23 D1,D2,D3,D4,D5,D6 FWD

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$

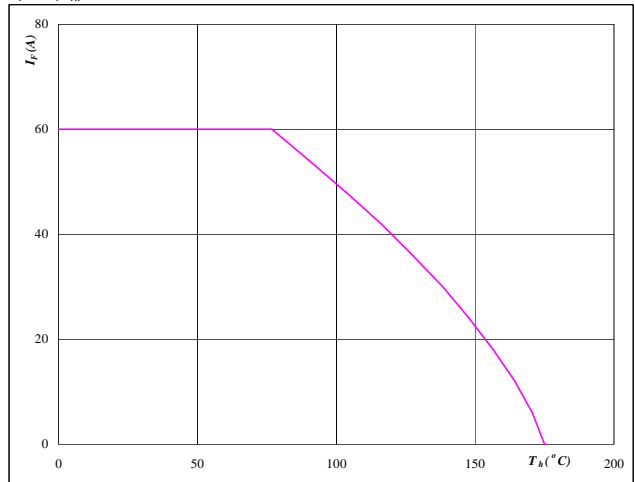


At
 $T_j = 175$ °C

Figure 24 D1,D2,D3,D4,D5,D6 FWD

Forward current as a function of heatsink temperature

$I_F = f(T_h)$



At
 $T_j = 175$ °C



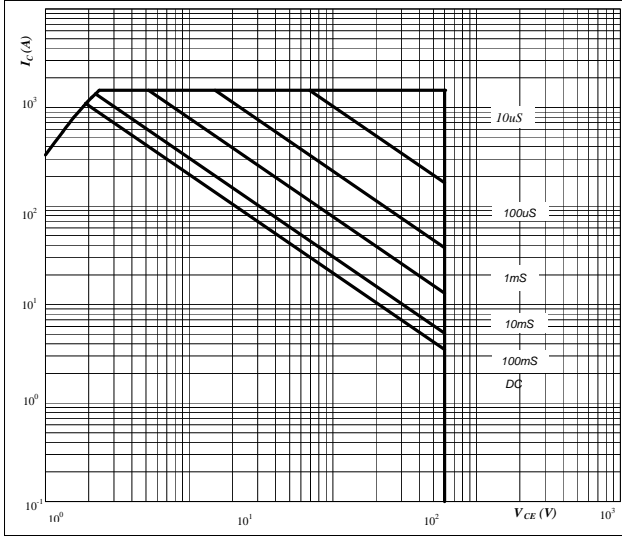
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T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b/D1,D2,D3,D4,D5,D6

Figure 25 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Safe operating area as a function of collector-emitter voltage

$I_C = f(V_{CE})$

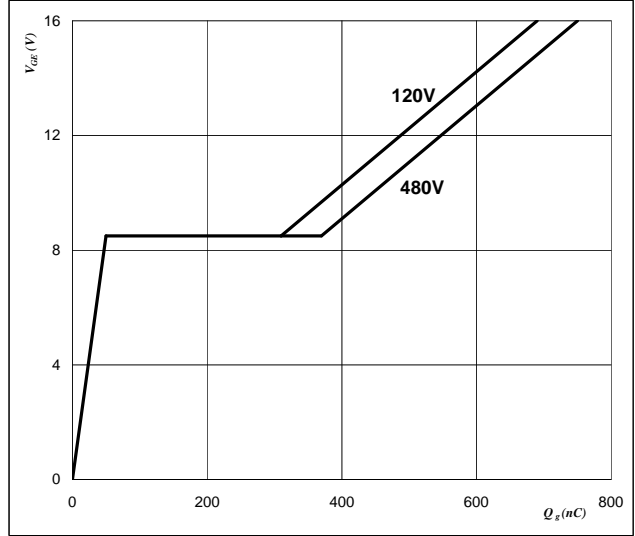


At
 D = single pulse
 $T_h = 80$ °C
 $V_{GE} = \pm 15$ V
 $T_j = T_{jmax}$ °C

Figure 26 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Gate voltage vs Gate charge

$V_{GE} = f(Q_{GE})$

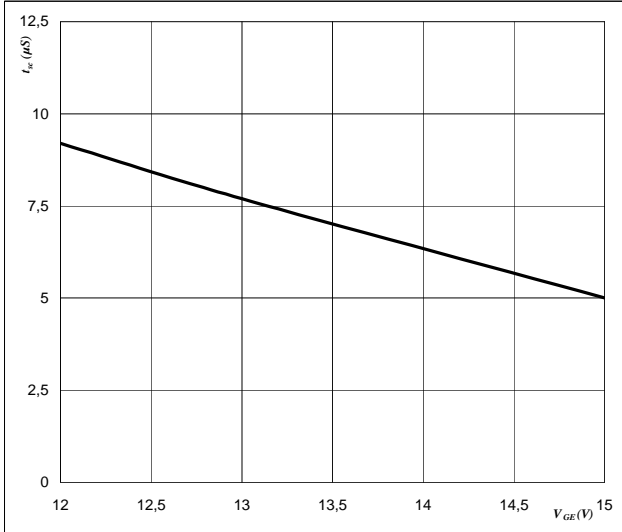


At
 $I_C = 100$ A

Figure 27 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Short circuit withstand time as a function of gate-emitter voltage

$t_{sc} = f(V_{GE})$

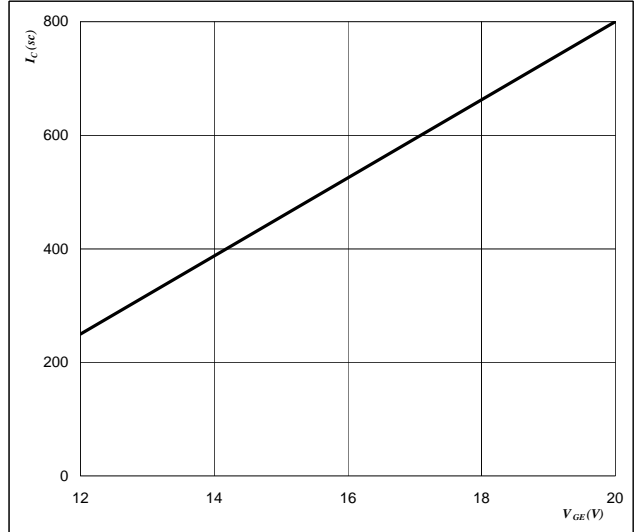


At
 $V_{CE} = 600$ V
 $T_j \leq 175$ °C

Figure 28 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Typical short circuit collector current as a function of gate-emitter voltage

$V_{GE} = f(Q_{GE})$

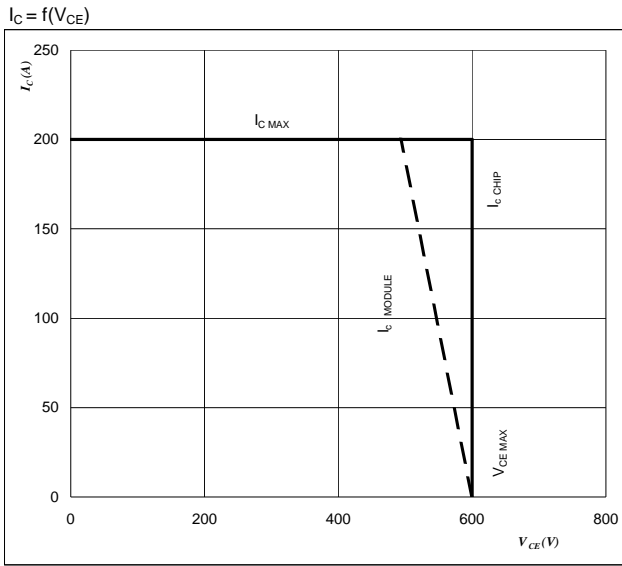


At
 $V_{CE} \leq 600$ V
 $T_j = 175$ °C



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Figure 29 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT
Reverse bias safe operating area



At
 $T_j = 150\ ^\circ\text{C}$
 $R_{gon} = 4\ \Omega$
 $R_{goff} = 4\ \Omega$

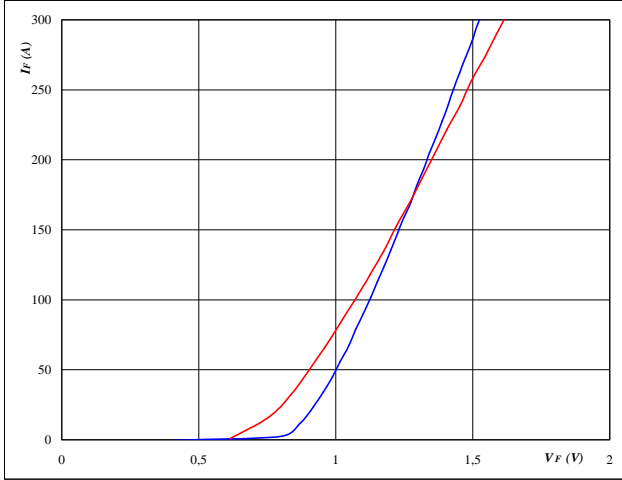


D7a-b,D8a-b

Figure 1 D7a-b,D8a-b

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$

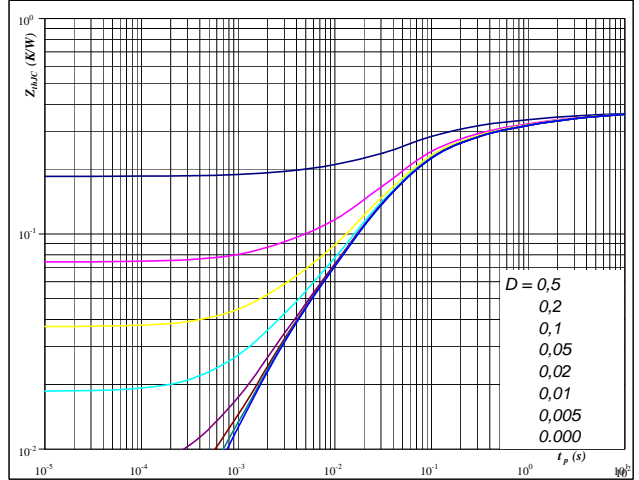


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $t_p = 250 \text{ } \mu\text{s}$

Figure 2 D7a-b,D8a-b

Diode transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$

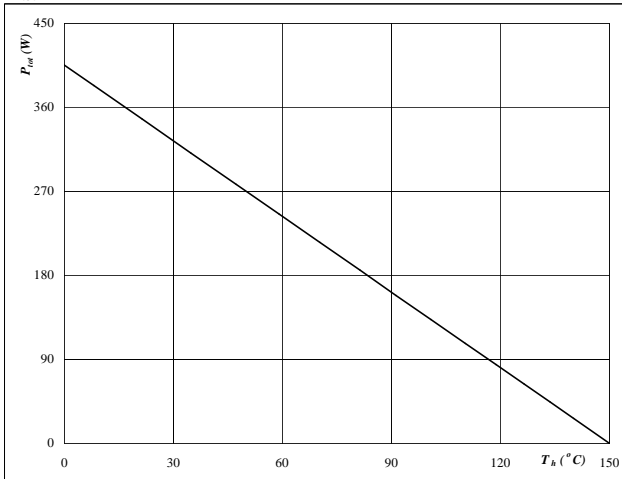


At
 $D = t_p / T$
 $R_{thJH} = 0,37 \text{ K/W}$

Figure 3 D7a-b,D8a-b

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$

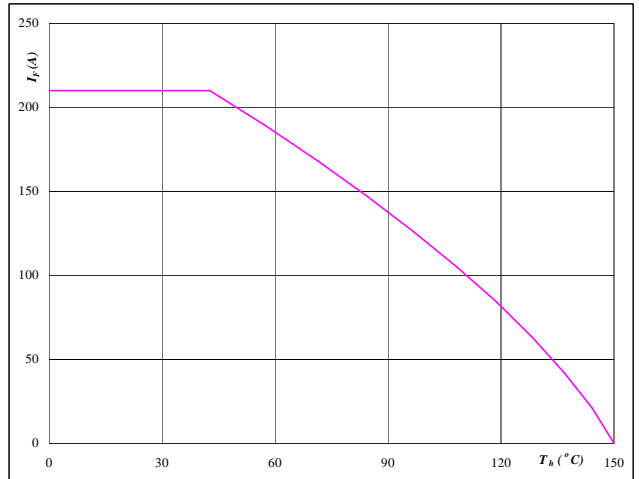


At
 $T_j = 150 \text{ } ^\circ\text{C}$

Figure 4 D7a-b,D8a-b

Forward current as a function of heatsink temperature

$I_F = f(T_h)$



At
 $T_j = 150 \text{ } ^\circ\text{C}$

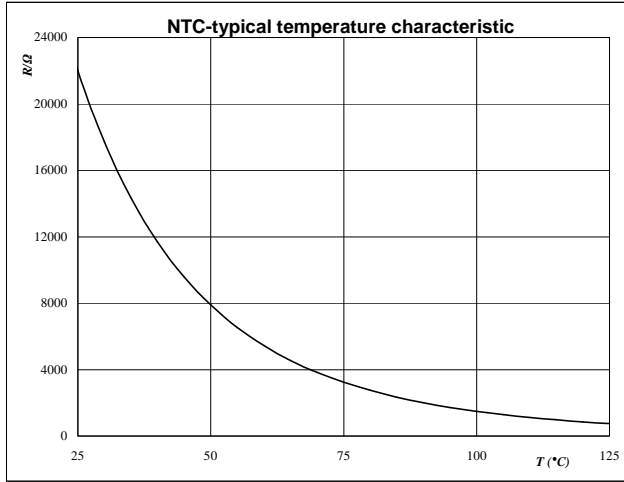


Thermistor

Figure 1 Thermistor

Typical NTC characteristic
as a function of temperature

$$R_T = f(T)$$



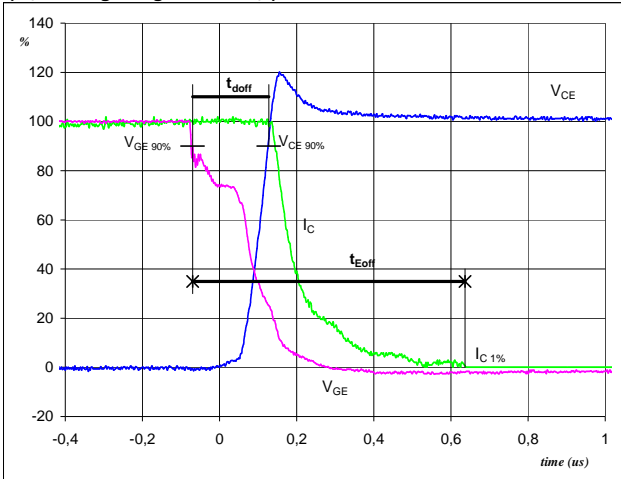


Switching Definitions Output Inverter

General conditions	
T_j	= 150 °C
R_{gon}	= 4 Ω
R_{goff}	= 4 Ω

Figure 1 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

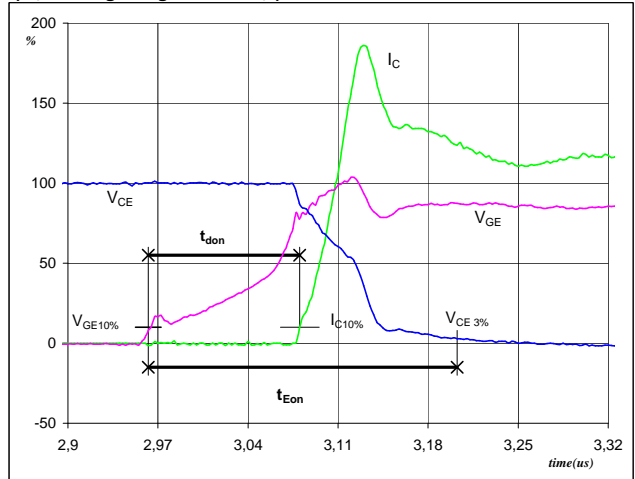
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
 (t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	300	V
$I_C(100\%) =$	100	A
$t_{doff} =$	0,20	μs
$t_{Eoff} =$	0,71	μs

Figure 2 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

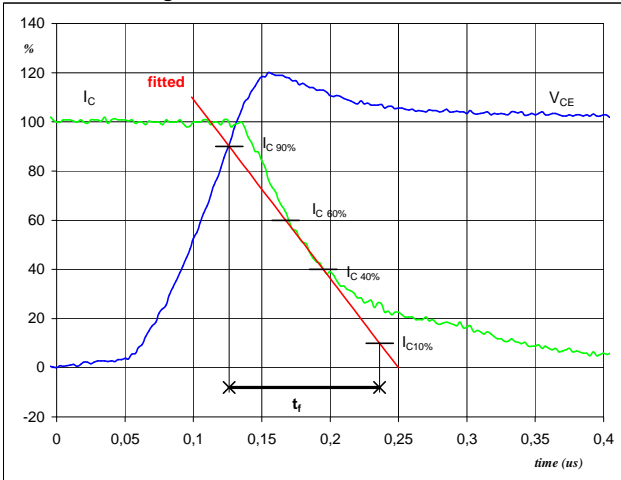
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
 (t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	300	V
$I_C(100\%) =$	100	A
$t_{don} =$	0,12	μs
$t_{Eon} =$	0,24	μs

Figure 3 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

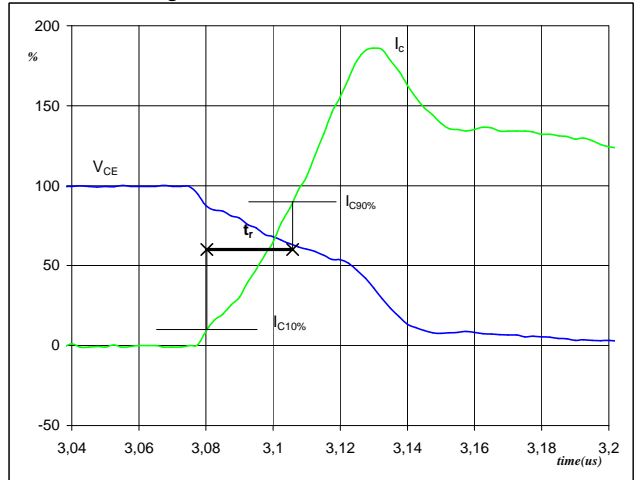
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%) =$	300	V
$I_C(100\%) =$	100	A
$t_f =$	0,10	μs

Figure 4 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT

Turn-on Switching Waveforms & definition of t_r

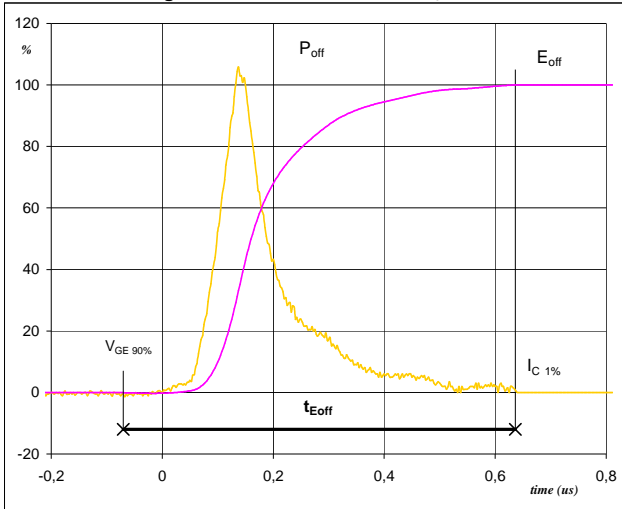


$V_C(100\%) =$	300	V
$I_C(100\%) =$	100	A
$t_r =$	0,03	μs



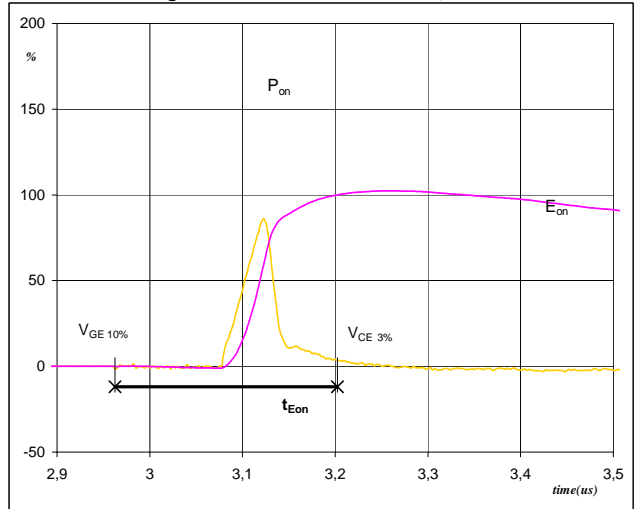
Switching Definitions Output Inverter

Figure 5 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT
Turn-off Switching Waveforms & definition of t_{Eoff}



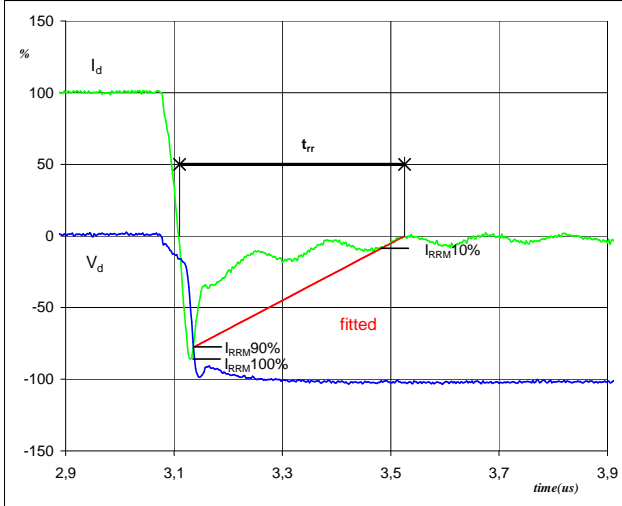
$P_{off}(100\%) = 29,91 \text{ kW}$
 $E_{off}(100\%) = 4,01 \text{ mJ}$
 $t_{Eoff} = 0,71 \text{ }\mu\text{s}$

Figure 6 T1a-b,T2a-b,T3a-b,T4a-b,T5a-b,T6a-b IGBT
Turn-on Switching Waveforms & definition of t_{Eon}



$P_{on}(100\%) = 29,91 \text{ kW}$
 $E_{on}(100\%) = 1,12 \text{ mJ}$
 $t_{Eon} = 0,24 \text{ }\mu\text{s}$

Figure 7 D1,D2,D3,D4,D5,D6 FWD
Turn-off Switching Waveforms & definition of t_{rr}



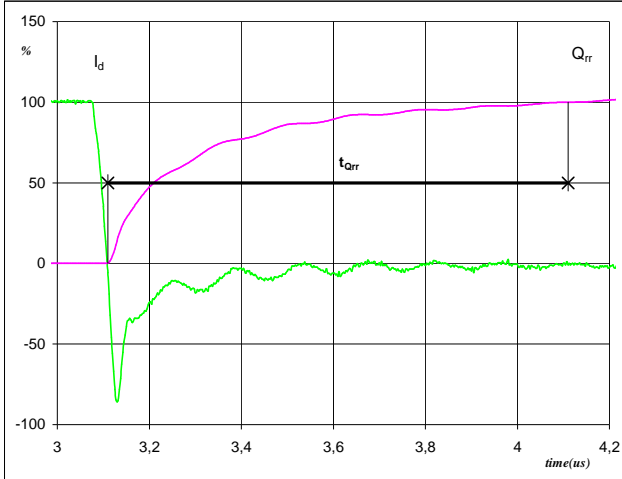
$V_d(100\%) = 300 \text{ V}$
 $I_d(100\%) = 100 \text{ A}$
 $I_{RRM}(100\%) = -87 \text{ A}$
 $t_{rr} = 0,27 \text{ }\mu\text{s}$



Switching Definitions Output Inverter

Figure 8 D1,D2,D3,D4,D5,D6 FWD

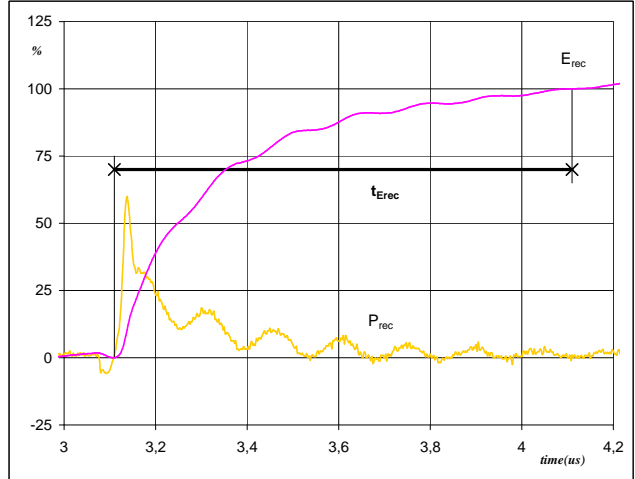
Turn-on Switching Waveforms & definition of t_{Qrr}
 (t_{Qrr} = integrating time for Q_{rr})



I_d (100%) =	100	A
Q_{rr} (100%) =	7,48	μC
t_{Qrr} =	1,00	μs

Figure 9 D1,D2,D3,D4,D5,D6 FWD

Turn-on Switching Waveforms & definition of t_{Erec}
 (t_{Erec} = integrating time for E_{rec})



P_{rec} (100%) =	29,91	kW
E_{rec} (100%) =	1,91	mJ
t_{Erec} =	1,00	μs

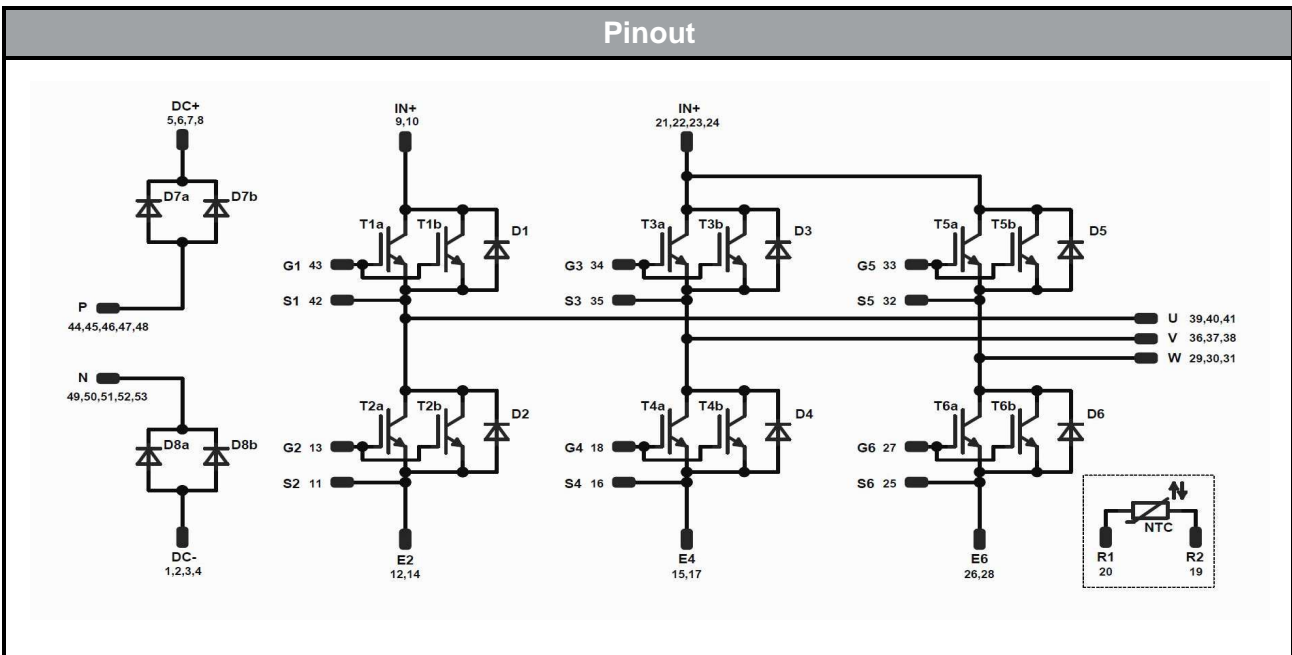


Ordering Code and Marking - Outline - Pinout

Ordering Code & Marking			
Version	Ordering Code	in DataMatrix as	in packaging barcode as
17mm housing	30-F206R6A100SB-M444E	M444-E	M444-E
17mm housing, without thermistor	30-F206R6A100SB01-M444E10	M444-E10	M444-E10

Outline

Pin table			Pin table		
Pin	X	Y	Pin	X	Y
1	712	0	29	0	372
2	68,7	0	30	2,5	372
3	66,2	0	31	5	372
4	63,7	0	32	7,8	372
5	55,95	0	33	10,6	372
6	53,45	0	34	18,45	372
7	55,95	2,8	35	2125	372
8	53,45	2,8	36	24,05	372
9	48,4	0	37	26,55	372
10	45,9	0	38	29,05	372
11	38,9	0	39	36,1	372
12	36,1	0	40	38,6	372
13	38,9	2,8	41	41,1	372
14	36,1	2,8	42	43,9	372
15	31,3	0	43	46,7	372
16	28,5	0	44	53,7	372
17	31,3	2,8	45	56,2	372
18	28,5	2,8	46	58,7	372
19	19,3	0	47	71,2	372
20	19,3	2,8	48	71,2	34,7
21	12,3	0	49	71,2	25,2
22	9,8	0	50	71,2	22,7
23	12,3	2,8	51	71,2	20,2
24	9,8	2,8	52	71,2	12,8
25	2,8	0	53	68,7	12,8
26	0	0			
27	2,8	2,8			
28	0	2,8			





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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.